

Product Specification

XBLW IRF7416T

P-Channel Enhancement Mode MOSFET

WEB | www.xinboleic.com



Description

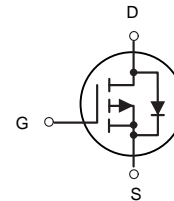
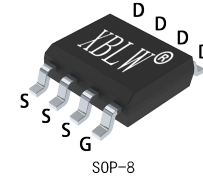
The IRF7416T uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as 2.5V. This device is suitable for use as a Battery protection or in other Switching application.

General Features

- $V_{DS} = -30V$ $I_D = -11A$
- $R_{DS(ON)} < 16m\Omega$ @ $V_{GS} = 10V$

Application

- Battery protection
- Load switch
- Uninterruptible power supply



P-Channel MOSFET

Package Marking and Ordering Information

| Product Model | Package Type | Marking | Packing | Packing Qty |
|---------------|--------------|----------|---------|--------------|
| XBLW IRF7416T | SOP-8 | IRF7416T | Tape | 3000Pcs/Reel |
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Absolute Maximum Ratings (Tc=25°C unless otherwise noted)

| Symbol | Parameter | Rating | Units |
|--------------------------|---|------------|-------|
| V_{DS} | Drain-Source Voltage | - 30 | V |
| V_{GS} | Gate-Source Voltage | ± 20 | V |
| $I_D @ T_A = 25^\circ C$ | Drain Current ³ , V_{GS} @ 10V | -11 | A |
| I_{DM} | Pulsed Drain Current ¹ | -40 | A |
| $P_D @ T_A = 25^\circ C$ | Total Power Dissipation | 3.7 | W |
| TSTG | Storage Temperature Range | -55 to 150 | °C |
| T_J | Operating Junction Temperature Range | -55 to 150 | °C |
| R_{thj-a} | Maximum Thermal Resistance, Junction-ambient ³ | 33.8 | °C/W |

Electrical Characteristics (T_J = 25°C, unless otherwise noted)

| Symbol | Parameter | Test Condition | Min. | Typ. | Max. | Units |
|--|--|---|------|------|------|-------|
| Off Characteristic | | | | | | |
| V _{(BR)DSS} | Drain-Source Breakdown Voltage | V _{GS} =0V, I _D = -250μA | -30 | - | - | V |
| I _{DSS} | Zero Gate Voltage Drain Current | V _{DS} = -30V, V _{GS} =0V, | - | - | -1 | μA |
| I _{GSS} | Gate to Body Leakage Current | V _{DS} =0V, V _{GS} = ±20V | - | - | ±100 | nA |
| On Characteristics | | | | | | |
| V _{GS(th)} | Gate Threshold Voltage | V _{DS} =V _{GS} , I _D = -250μA | -1.0 | -1.6 | -2.5 | V |
| R _{DS(on)} | Static Drain-Source on-Resistance Note3 | V _{GS} = -10V, I _D = -10A | - | 13 | 16 | mΩ |
| | | V _{GS} = -4.5V, I _D = -5A | - | 18 | 27 | |
| Dynamic Characteristics | | | | | | |
| C _{iss} | Input Capacitance | V _{DS} = -15V, V _{GS} =0V, f=1.0MHz | - | 1330 | - | pF |
| C _{oss} | Output Capacitance | | - | 183 | - | pF |
| C _{rss} | Reverse Transfer Capacitance | | - | 156 | - | pF |
| Q _g | Total Gate Charge | V _{DS} = -15V, I _D = -5A, V _{GS} = -10V | - | 22 | - | nC |
| Q _{gs} | Gate-Source Charge | | - | 1.0 | - | nC |
| Q _{gd} | Gate-Drain(“Miller”) Charge | | - | 1.8 | - | nC |
| Switching Characteristics | | | | | | |
| t _{d(on)} | Turn-on Delay Time | V _{DD} = -15V, I _D = -10A, V _{GS} =-10V, R _{GEN} =2.5Ω | - | 9 | - | ns |
| t _r | Turn-on Rise Time | | - | 13 | - | ns |
| t _{d(off)} | Turn-off Delay Time | | - | 48 | - | ns |
| t _f | Turn-off Fall Time | | - | 20 | - | ns |
| Drain-Source Diode Characteristics and Maximum Ratings | | | | | | |
| I _S | Maximum Continuous Drain to Source Diode Forward Current | | - | - | -11 | A |
| I _{SM} | Maximum Pulsed Drain to Source Diode Forward Current | | - | - | -40 | A |
| V _{SD} | Drain to Source Diode Forward Voltage | V _{GS} =0V, I _S = -15A | - | -0.8 | -1.2 | V |
| t _{rr} | Reverse Recovery Time | T _J =25℃, | - | 64 | - | ns |
| Q _{rr} | Reverse Recovery Charge | V _{DD} = -24V, I _F =-2.8A, dI/dt=-100A/μs | - | 25 | - | nC |

Notes:1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature

2. EAS condition: T_J=25°C, V_{GS}=10V, R_G=25Ω, L=0.5mH, I_{AS}=-12.7A

3. Pulse Test: Pulse Width≤300μs, Duty Cycle≤0.5%

Typical Characteristics

Figure1: Output Characteristics

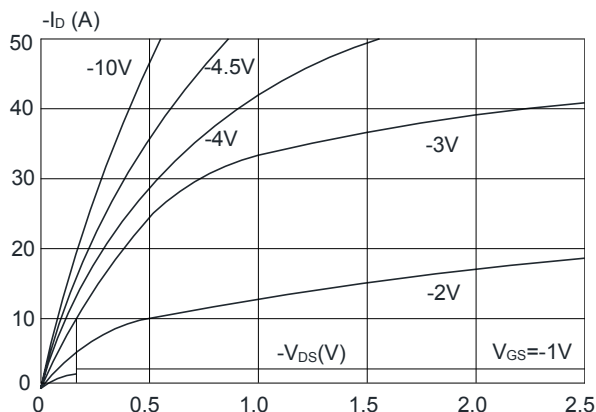


Figure 2: Typical Transfer Characteristics

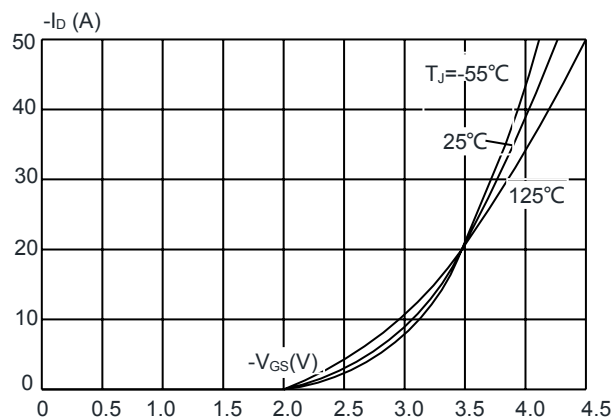


Figure 3: On-resistance vs. Drain Current

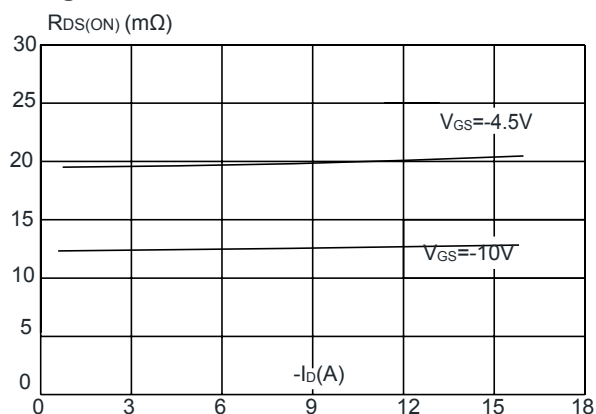


Figure 4: Body Diode Characteristics

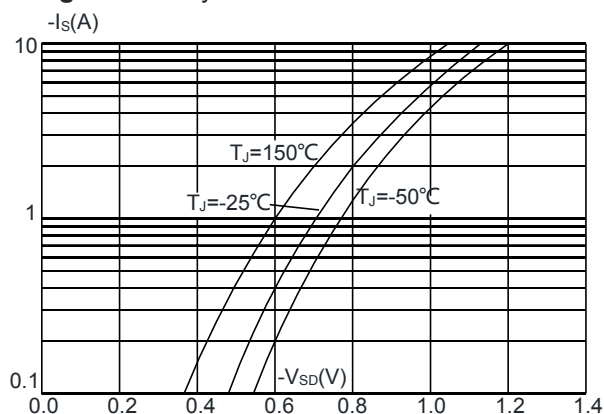


Figure 5: Gate Charge Characteristics

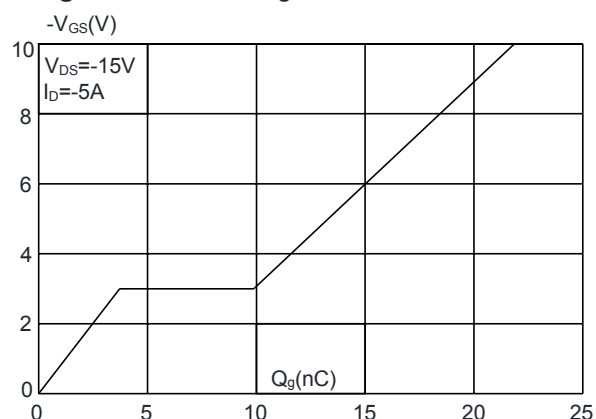


Figure 6: Capacitance Characteristics

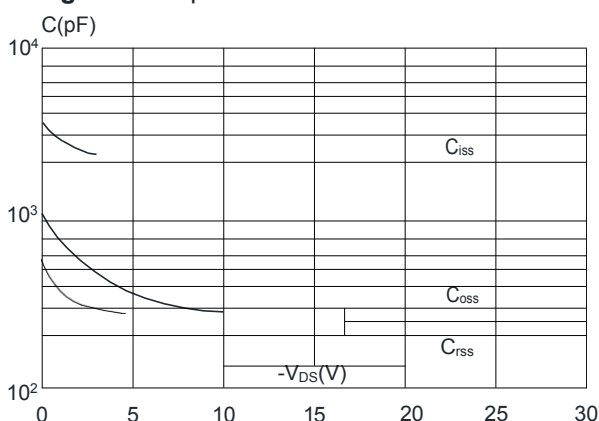


Figure 7: Normalized Breakdown Voltage vs. Junction Temperature

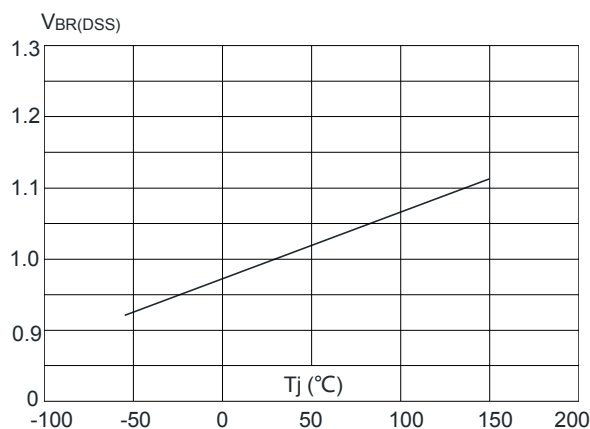


Figure 8: Normalized on Resistance vs. Junction Temperature

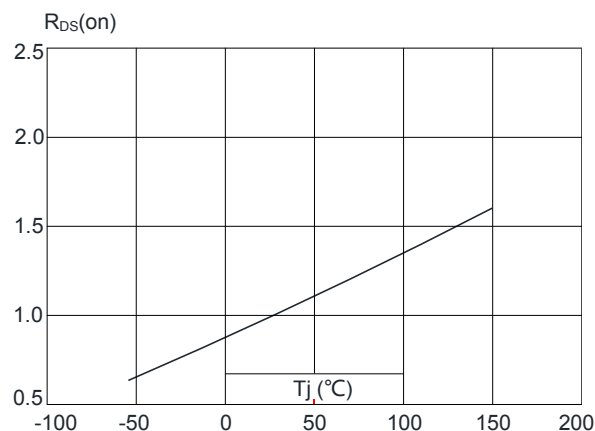


Figure 9: Maximum Safe Operating Area

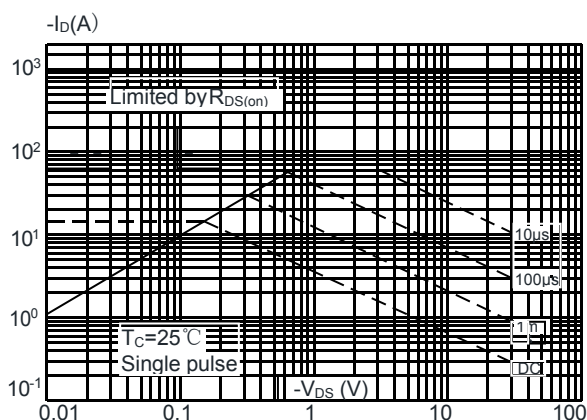


Figure 10: Maximum Continuous Drain Current vs. Ambient Temperature

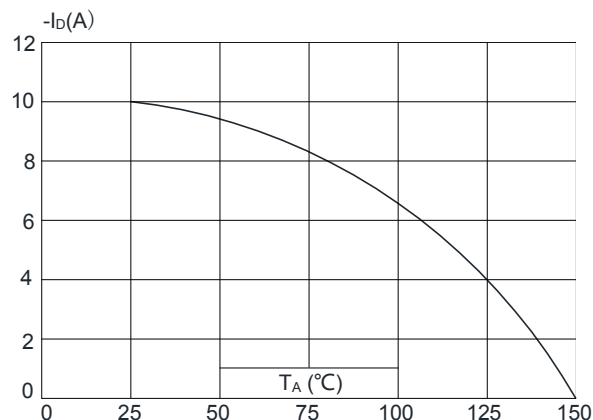
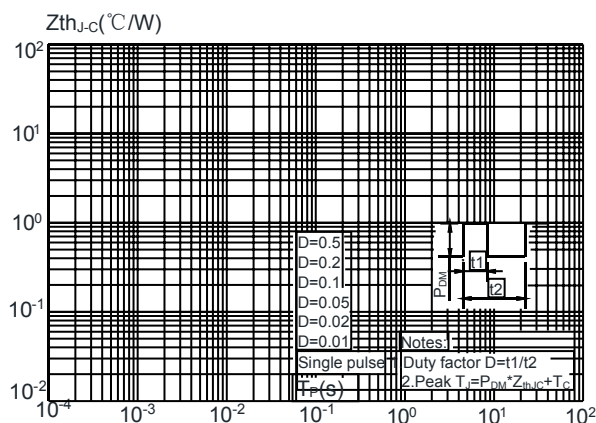
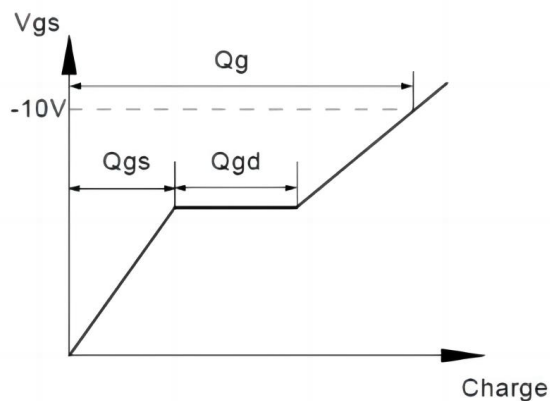
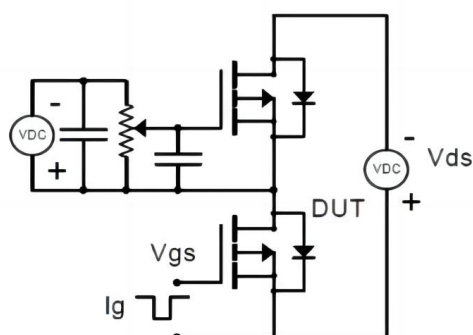


Figure.11: Maximum Effective Transient Thermal Impedance, Junction-to-Case

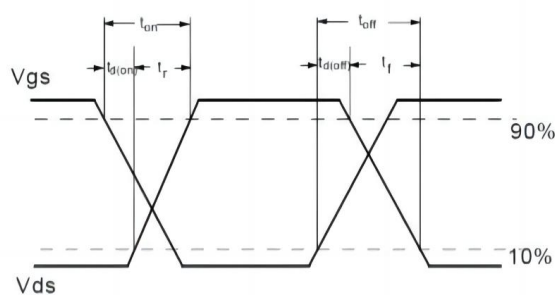
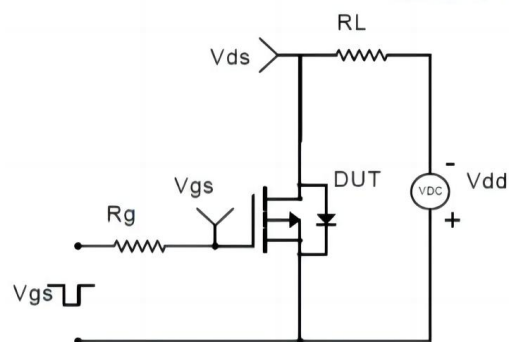


Test Circuit

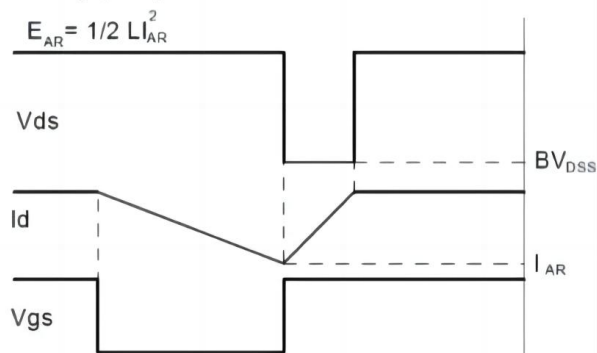
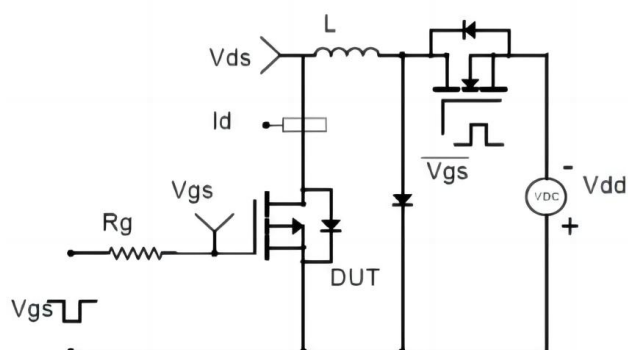
Gate Charge Test Circuit & Waveform



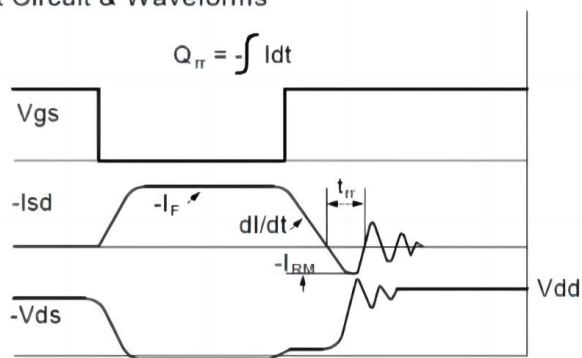
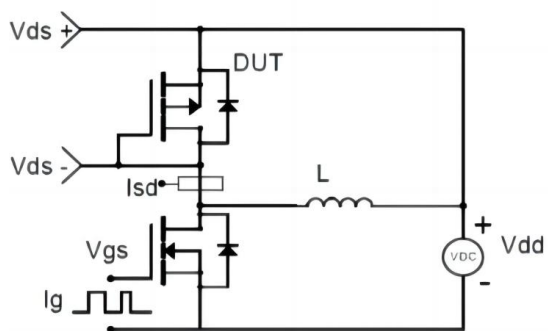
Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching (UIS) Test Circuit & Waveforms

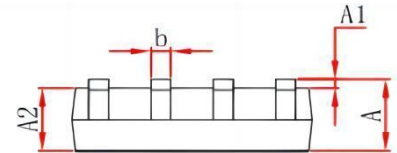
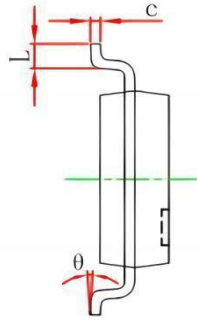
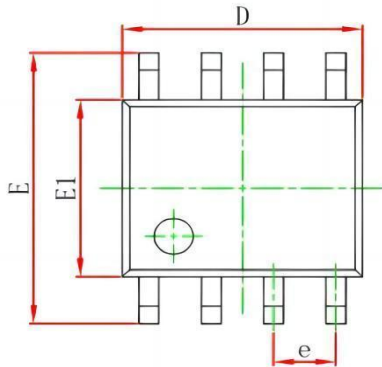


Diode Recovery Test Circuit & Waveforms

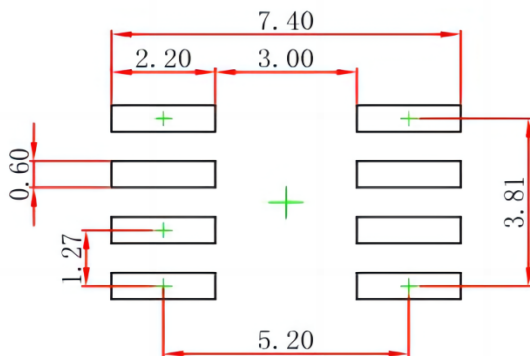


Package Outline Dimensions

SOP-8



| Symbol | Dimensions In Millimeters | | Dimensions In Inches | |
|--------|---------------------------|-------|----------------------|-------|
| | Min | Max | Min | Max |
| A | 1.350 | 1.750 | 0.053 | 0.069 |
| A1 | 0.100 | 0.250 | 0.004 | 0.010 |
| A2 | 1.350 | 1.550 | 0.053 | 0.061 |
| b | 0.330 | 0.510 | 0.013 | 0.020 |
| c | 0.170 | 0.250 | 0.007 | 0.010 |
| D | 4.800 | 5.000 | 0.189 | 0.197 |
| e | 1.270 (BSC) | | 0.050 (BSC) | |
| E | 5.800 | 6.200 | 0.228 | 0.244 |
| E1 | 3.800 | 4.000 | 0.150 | 0.157 |
| L | 0.400 | 1.270 | 0.016 | 0.050 |
| θ | 0° | 8° | 0° | 8° |



Note:

1. Controlling dimension: In millimeters.
2. General tolerance: $\pm 0.05\text{mm}$.
3. The pad layout is for reference purposes only.

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